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300mK Strap Supports & Light Baffles -

Declared Processes List

300mK Strap Supports & Light Baffles **Declared Processes List**

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Update history

Date	Version	Remarks
08/02/03	1.0	First Issue for DDR

List of Acronyms

Term	Meaning LISU UI	Term	Meaning
AD		IR	Infrared
	Applicable Document		
ADC	Analogue to Digital Converter	IRD	Instrument Requirements Document
AIV	Assembly, Integration and Verification	IRTS	Infrared Telescope in Space
AME	Absolute Measurement Error	ISM	Interstellar Medium
AOCS	Attitude and Orbit Control System	JFET	Junction Field Effect Transistor
APART	Arizona's Program for the Analysis of Radiation Transfer	ISO	Infrared Space Observatory
APE	Absolute Pointing Error	LCL	Latching Current Limiter
ASAP	Advanced Systems Analysis Program	LIA	Lock-In Amplifier
ATC	Astronomy Technology Centre, Edinburgh	LVDT	Linear Variable Differential Transformer
AVM	Avionics Model	LWS	Long Wave Spectrometer (an instrument used on ISO)
BDA	Bolometer Detector Array	MAC	Multi Axis Controller
BFL	Back Focal Length	MAIV	Manufacturing, Assembly, Integration and Verification
BRO	Breault Research Organization	MCU	Mechanism Control Unit = HSMCU
BSM	Beam Steering Mirror	MGSE	Mechanical Ground Support Equipment
CBB	Cryogenic Black Body	M-P	Martin-Puplett
CDF	Cardiff, Department of Physics & Astronomy	NEP	Noise Equivalent Power
CDMS	Command and Data Management System	NTD	Neutron Transmutation Doped
CDMU	Command and Data Management System Command and Data Management Unit	OBS	On-Board Software
CDR	Critical Design Review	OGSE	Optical Ground Support Equipment
CEA	Commissariat a l'Energie Atomique	OMD	Observing Modes Document
CMOS	Complimentary Metal Oxide Silicon	OPD	Optical Path Difference
CoG	Centre of Gravity	PACS	Photodetector Array Camera and Spectrometer
CPU	Central Processing Unit	PCAL	Photometer Calibration source
CQM	Cryogenic Qualification Model	PFM	Proto-Flight Model
CVV	Cryostat Vacuum Vessel	PID	Proportional, Integral and Differential (used in the context of feedback control loop architecture)
DAC	Digital to Analogue Converter	PLW	Photometer, Long Wavelength
DAQ	Data Acquisition	PMW	Photometer, Medium Wavelength
DCU	Detector Control Unit = HSDCU	POF	Photometer Observatory Function
DDR	Detailed Design Review	PROM	Programmable Read Only Memory
DM	Development Model	PSW	Photometer, Short Wavelength
DPU	Digital Processing Unit = HSDPU	PUS	Packet Utilisation Standard
DSP	Digital Signal Processor	RAL	Rutherford Appleton Laboratory,
DQE	Detective Quantum Efficiency	RD	Reference Document
EDAC	Error Detection and Correction	RMS	Root Mean Squared
EGSE	Electrical Ground Support Equipment	SCAL	Spectrometer Calibration Source
EM	Engineering Model	SCUBA	Submillimetre Common User Bolometer Array
EMC	Electro-magnetic Compatibility	SED	Spectral Energy Distribution
EMI	Electro-magnetic Interference	SMEC	Spectrometer Mechanics
ESA	European Space Agency	SMPS	Switch Mode Power Supply
FCU	FCU Control Unit = HSFCU	SOB	SPIRE Optical Bench
FIR	Far Infrared	SOF	Spectrometer Observatory Function
FIRST	Far Infra-Red and Submillimetre Telescope	SPIRE	Spectrolleter Observatory Function Spectral and Photometric Imaging Receiver
FOV	Field of View	SRAM	Static Random Access Memory
F-P	Fabry-Perot	SSSD	SubSystem Specification Document
F-P FPGA	Field Programmable Gate Array	STP	Standard Temperature and Pressure
FPU	Focal Plane Unit	SVM	Service Module
		TBC	To Be Confirmed
FS FTS	Flight Spare Fourier Transform Spectrometer	TBD	To Be Determined
F15 FWHM	Full Width Half maximum	TC	
			Telecommand
GSFC	Goddard Space Flight Center	URD	User Requirements Document
HK	House Keeping	UV	Ultra Violet
HOB	Herschel Optical Bench	WE	Warm Electronics
HPDU	Herschel Power Distribution Unit	ZPD	Zero Path Difference
HSDCU	Herschel-SPIRE Detector Control Unit	_	
HSDPU	Herschel-SPIRE Digital Processing Unit	_	
HSFCU	Herschel-SPIRE FPU Control Unit		
HSO	Herschel Space Observatory		
IF	Interface		
IID-A	Instrument Interface Document - Part A		
	Instrument Interface Document - Part B		
IID-B	instrument interface Document - Part B		the state of the s

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1. Scope

This document presents the processes used during the manufacture and assembly of the 300mK thermal strap supports and light baffles.

2. Documents

2.1. Applicable documents

All applicable documents are listed in the AD chapter of the CIDL (HSO-CDF-LI-029).

2.2. Reference documents

RD1 ECSS-Q-70A Materials Mechanical Parts and Processes

RD2 ESA PSS-01-700 The Technical Reporting and Approval Procedure for

Materials and Processes

3. Declared processes list

Processes should be grouped in the table below:

Group Type	Used
1. Adhesive Bonding	✓
Composite Manufacturing	N/A
3. Encapsulation/Molding	N/A
4. Painting/Coating	✓
5. Cleaning	✓
6. Welding/Brazing	N/A
7. Crimping/Stripping/Wire Wrapping	N/A
8. Soldering	N/A
9. Surface Treatment	✓
10. Plating	N/A
11. Machining	✓
12. Forming	N/A
13. Heat Treatment	N/A
14. Special Fabrication	N/A
15. Marking	✓
16. Miscellaneous Processes	√
17. Inspection Procedure	✓

	Issue No	1		DE	CLARED PROCE	CESSES LIST HSO-CDF-LI-043-1.0						
EXP	PROJECT: HERSCHEL SPACE OBSERVATORY EXPERIMENT: SPIRE EXPERIMENTERS: Cardiff University PREPARED BY: P.Hargrave			RY		G	roup 1 – Ad	hesive Bond	ling			
Itm No	Process	Specific	cation	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approval Status		Comments	
		1.Manufact 2.Specification			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status		
1-1	Use of Epotek 920	1.Cardiff L 2.HSO-CD xxx		Bonding / containment of free ends of Kevlar cords	1.Kevlar cords 2.		1. 2.10-2	Not critical	Common practice @ UWC			

	Issue No	1	DE	CLARED PROCI	ESSES LIS	<u>T</u>				
PROJECT: HERSCHEL SPACE OBSERVATORY EXPERIMENT: SPIRE EXPERIMENTERS: Cardiff University PREPARED BY: P.Hargrave						Grou	p 2- Compo	site Manufac	cturing	
Itm No	Process	Specificat	ion Description/identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status		Comments
		1.Manufacture 2.Specificatio		1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status	
_										

	Issue No 1 <u>DECLARED PR</u>					ESSES LIST	<u></u>				
PROJECT: HERSCHEL SPACE OBSERVATORY EXPERIMENT: SPIRE EXPERIMENTERS: Cardiff University PREPARED BY: P.Hargrave			RY	Group 3 Encapsulation/Molding							
Itm No	Process	Specific	cation	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approval Status		Comments
		1.Manufac 2.Specifica			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status	

	Issue No	1	<u>DE</u>	CLARED PROC	ESSES LIS	<u>T</u>				
EXPE	JECT: ERIMENT: ERIMENTERS: PARED BY:	HERSCHEL SF SPIRE Cardiff Univers P.Hargrave	PACE OBSERVATO	PRY			Group 4 Pai	nting/Coatir	ıg	
Itm No	Process	Specification	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Statu		Comments
		1.Manufacturer 2.Specification		1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status	
4-1	Coating of light baffle components	1.Cardiff Universit 2.HSO-CDF-PR- xxx	y Application of black coating to light baffle components	1.LB immer hub B		1. 2.10-1	Critical			

	Issue No	1		DEC	CLARED PROCI	ESSES LIST	<u> </u>				
EXPE	JECT: ERIMENT: ERIMENTERS: PARED BY:	SPIRE	University	CE OBSERVATOR	RY		Group 5 Cleaning				
Itm No	Process	Specific	cation	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approva Status	I	Comments
		1.Manufac 2.Specifica			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Statu s	
5-1	Cleaning of individual items	1.Cardiff U 2.HSO-CD xxx	F-PR-	Cleaning of individual items before assembly / integration	1.All items		1.N/A 2.	Not critical			
5-2	Cleaning of final assemblies	1.Cardiff U 2.HSO-CD xxx		Cleaning of complete photometer support and light baffle assemblies to remove particular and molecular contaminants	1.Photometer support, Light baffle			Critical	Cleanliness & contamination monitoring		

	Issue No	1		<u>DE</u>	CLARED PROCE	ESSES LIST	<u>.</u>				
EXPE EXPE	JECT: ERIMENT: ERIMENTERS: PARED BY:	SPIRE	University	CE OBSERVATO	RY		G	Group 6 Wel	ding & Brazi		
Itm No	Process	Specific	cation	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status	al	Comments
		1.Manufac 2.Specifica			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status	

	Issue No	1		DE	CLARED PROCE	SSES LIST					
EXPE	PROJECT: HERSCHEL SPACE OBSERVATORY EXPERIMENT: SPIRE EXPERIMENTERS: Cardiff University PREPARED BY: P.Hargrave			RY		Group 7	Crimping/St	ripping/Wire	Wrapp	ing	
Itm No	Process	Specific	cation	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approval Status		Comments
		1.Manufac 2.Specifica			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status	

	Issue No	1		CLARED PROC	ESSES LIS	<u>T</u>					
EXPE EXPE	PROJECT: HERSCHEL SPACE OBSERVATORY EXPERIMENT: SPIRE EXPERIMENTERS: Cardiff University PREPARED BY: P.Hargrave			PRY	Group 8 Soldering						
Itm No	Process	Specificat	ion Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status		Comments	
		1.Manufacture 2.Specificatio		1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status		

	Issue No	1	<u>DE</u>	CLARED PROCE	ESSES LIS	<u>T</u>					
EXPE	JECT: ERIMENT: ERIMENTERS: PARED BY:	HERSCHEL SPA SPIRE Cardiff Universit P.Hargrave	CE OBSERVATOI y	RY	Group 9 Surface Treatment						
Itm No	Process	Specification	Description/ identification	Use and location	User code	Associated DML items	Criticality of process		Approval Comments Status		
		1.Manufacturer 2.Specification		1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status		
9-1	Aluchrom 1200	1.Walton Plating LTD 2.TBD	Aluchrom 1200 surface treatment of aluminium components	1.Photometer support base, light baffle base, light baffle cover	WPL	1. Photometer support base, light baffle base, light baffle cover 2.N/A	Not critical				
9-2	Electropolishi ng	1.Ashton & Moore Ltd, Birmingham, UK 2.TBD	Electropolish stainless steel components to smooth Kevlar guide holes	1.All stainless steel components, except capstans	AML	1. 2.5-1	Critical	Inspection report. Certificates of conformance			

	Issue No	1		CLARED PROC	ESSES LIS	<u>T</u>					
EXPE EXPE	PROJECT: HERSCHEL SPACE OBSERVATORY EXPERIMENT: SPIRE EXPERIMENTERS: Cardiff University PREPARED BY: P.Hargrave			RY	Group 10 Plating						
Itm No	Process	Specification	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status		Comments	
		1.Manufacturer 2.Specification		1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status		

	Issue No	1		<u>DE</u>	CLARED PROCI	ESSES LIS	<u>T</u>				
EXPE	ECT: RIMENT: RIMENTERS: ARED BY:	HERSCH SPIRE Cardiff U P.Hargra	niversity	CE OBSERVATOI	RY			Group 11	Machining		
Itm No	Process	Specifica	ition	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status		Comments
		1.Manufactu 2.Specificati			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status	
11-1	Machining of mechanical parts	1.The Mach Centre, Abir Oxon, UK 2.HSO-CDF xxx	ngdon,	Machining of stainless steel, aluminium & Torlon parts	See drawing list	TMC		Critical	Dimensional check & certificates of conformance		

	Issue No	1		CLARED PROC	ESSES LIS	<u>T</u>					
EXPE EXPE	PROJECT: HERSCHEL SPACE OBSERVATORY EXPERIMENT: SPIRE EXPERIMENTERS: Cardiff University PREPARED BY: P.Hargrave			RY	Group 12 Forming						
Itm No	Process	Specification	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status		Comments	
		1.Manufacturer 2.Specification		1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status		

	Issue No	1	DE	CLARED PROCE	SSES LIS	<u>T</u>						
EXPE	ECT: RIMENT: RIMENTERS: ARED BY:	SPIRE	Cardiff University			Group 13 Heat Treatment						
Itm No	Process	Specification	on Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Statu		Comments		
		1.Manufacture 2.Specification		1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status			
13-1	Pre- conditioning of Kevlar	1.Cardiff Unive 2.HSO-CDF-P xxx		1.Photometer support & light baffle assemblies, prior to final tensioning			Not critical					
13-2	Baking of assemblies under vacuum	1.Cardiff Unive 2.HSO-CDF-P xxx	ersity Final bake-out.	1.Photometer support & light baffle assemblies			Critical					

	Issue No	1		<u>DE</u>	CLARED PROC	ESSES LIST	<u> </u>					
EXPE	PROJECT: HERSCHEL SPACE OBSERVATORY EXPERIMENT: SPIRE EXPERIMENTERS: Cardiff University PREPARED BY: P.Hargrave				RY	Group 14 Special Fabrication						
Itm No	Process	Specific	cation	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approval Status		Comments	
		1.Manufac 2.Specifica			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status		

	Issue No	1		DEC	CLARED PROCE	ESSES LIST	<u> </u>				
EXPE	ECT: RIMENT: RIMENTERS: ARED BY:	HERSCHI SPIRE Cardiff Ur P.Hargrav	niversity	E OBSERVATO	RY			Group 1	5 Marking		
Itm No	Process	Specifica		Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status	al	Comments
		1.Manufactu 2.Specification			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status	
15-1	Marking of individual items	1.TMC 2.As per dra	wings	Marking of individual items	All items			Not critical			

	Issue No	1	DE	CLARED PROCE	SSES LIS	<u>T</u>					
EXPE	ECT: RIMENT: RIMENTERS: ARED BY:	HERSCHEL S SPIRE Cardiff Univer P.Hargrave	PACE OBSERVATO	PRY	Group 16 Miscellaneous Processes						
Itm No	Process	Specification	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status	al S	Comments	
		1.Manufacturer 2.Specification		1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status		
16-1	Verification of tension in Kevlar cords	1.Cardiff University 2.HSO-CDF-PR-xxx	ty To verify tension on Kevlar cords	1.Kevlar cords & inner hubs			Not critical				

	Issue No 1 <u>DECLARED PR</u>					ESSES LIS	<u> </u>					
EXPE	ECT: RIMENT: RIMENTERS: ARED BY:	HERSCHEL SPACE OBSERVATORY SPIRE Cardiff University P.Hargrave				Group 17 Inspection Procedure						
Itm No	Process	Specific	ation	Description/ identification	Use and location	User code	Associated DML items	Criticality of process	Approv Status	Comments		
		1.Manufact 2.Specifica			1.Part 2.Use		1.Part 2.Material		Justif. for approval	Status		
17-1	Kevlar inspection	1.Cardiff U 2.HSO-CD xxx		Inspection of Kevlar routing and integrity	1.Photometer support assembly, light baffle assembly		1. 2.20-1	Critical	Inspection report			